



Data Sheet

Customer:

Part No:

Sample No:

Description:

Item No:

CL-5014UWC1C-010-UWW

5Ø Lamp White Color

Customer			
Check	Inspection	Approval	Date

Features

Low Power Consumption

High Efficiency

Round Type

T1 (5mm) Diameter

With Flange

Solder Leads Without Stand-off

Compliant With RoHS

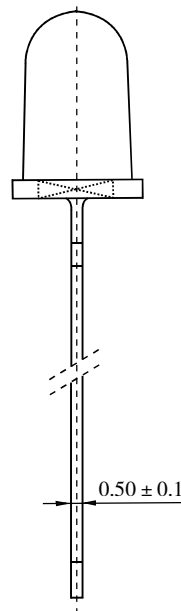
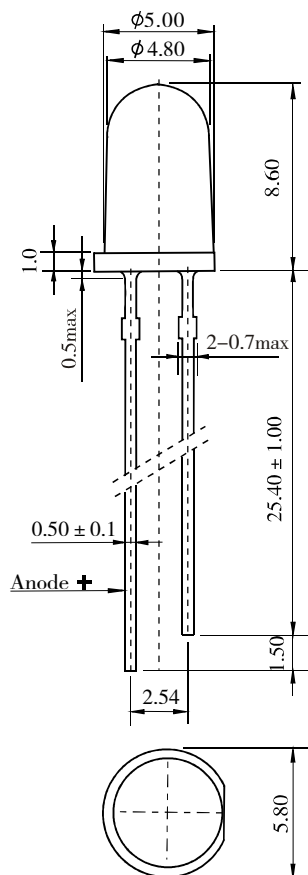
Descriptions

Chip Material: InGaN/GaN

Emitting Color: Warm White

Lens Color: Water Clean

Outline Drawing



ATTENTION



OBSERVE PRECAUTIONS
FOR HANDLING
ELECTROSTATIC
SENSITIVE DEVICES

Tolerance is $\pm 0.25\text{mm}$ unless otherwise noted, Unit=mm
Pin bending $\leq \text{length} \times 1\%$

Electrical Optical Characteristics (Ta=25°C)

Parameter	Symbol	White			Unit	Test Condition
		Min	Typ	Max		
Forward Voltage	V _F	---	3.20	3.60	V	IF=20mA
Luminous Intensity	I _V	11160	19000	---	med	IF=20mA
Chromaticity Coordinates (Tolerance: ± 0.01)	X	---	0.4408	---	nm	IF=20mA
	Y	---	0.4131	---	nm	IF=20mA
Spectral Line half-width	Δλ	---	30	---	nm	IF=20mA
Reverse Leakage Current	I _R	---	---	50	μA	VR=5V
Viewing Angle	2θ _{1/2}	---	20	---	Deg	IF=20mA

Absolute Maximum Parameters (Ta=25°C)

Parameter	Symbol	Condition	Rating	Unit
Power Dissipation	P _D	---	120	mW
Reverse Voltage	V _R	---	5	V
Forward Average Current	I _F	---	30	mA
Temperature Coefficient	I/C	---	0.4	mA/ °C
Pulse Current	IFP	Duty=1/10,1kHz	100	mA
Operating Temperature Range	T _{opr}	---	-25 ~ +85	°C
Storage Temperature Range	T _{stg}	---	-30 ~ +100	°C
Soldering Condition	T _{sd}	---	260°C/5sec	°C

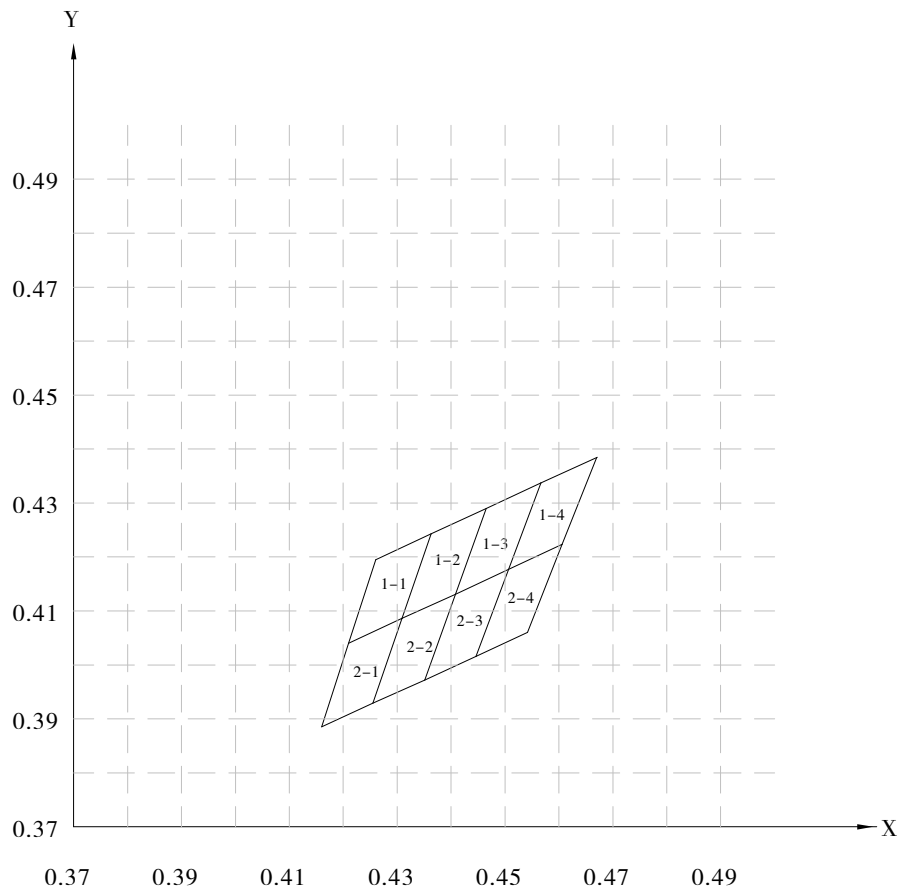
NOTE:

Luminous Intensity Measurement allowance is ± 10%.

2θ_{1/2} is the off-axis angle at which the luminous intensity is half the axial luminous intensity.

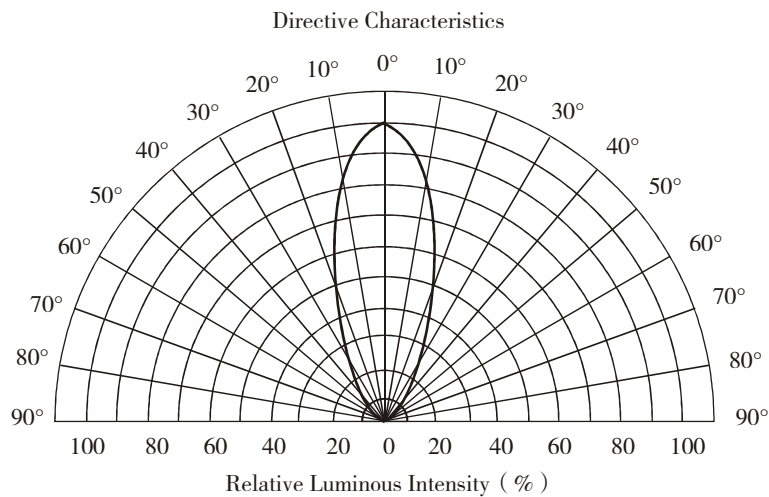
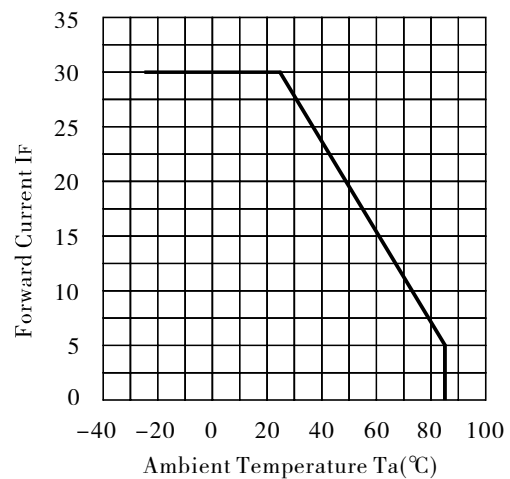
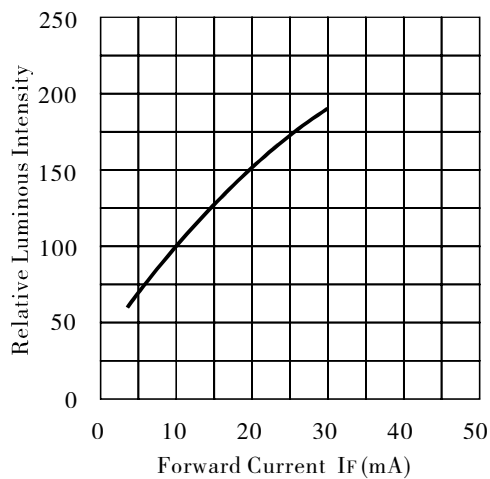
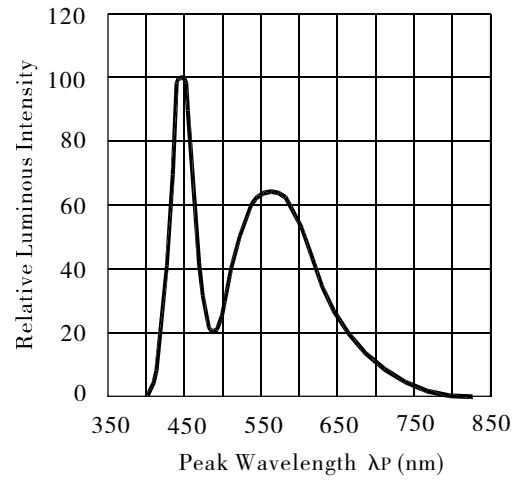
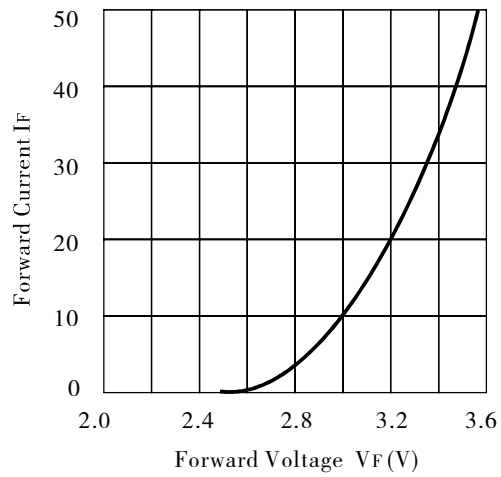
The dominant wavelength is derived from the CIE chromaticity diagram and represents the single wavelength which defines the color of the device.

Color distinguishes Bin specifications



坐标 BIN	X1	Y1	X2	Y2	X3	Y3	X4	Y4
1-1	0.4210	0.4040	0.4260	0.4195	0.4363	0.4243	0.4309	0.4086
2-1	0.4160	0.3885	0.4210	0.4040	0.4309	0.4086	0.4255	0.3929
1-2	0.4309	0.4086	0.4363	0.4243	0.4465	0.4290	0.4408	0.4131
2-2	0.4255	0.3929	0.4309	0.4086	0.4408	0.4131	0.4351	0.3972
1-3	0.4408	0.4131	0.4465	0.4290	0.4567	0.4337	0.4507	0.4177
2-3	0.4351	0.3972	0.4408	0.4131	0.4507	0.4177	0.4446	0.4016
1-4	0.4507	0.4177	0.4567	0.4337	0.4670	0.4385	0.4606	0.4223
2-4	0.4446	0.4016	0.4507	0.4177	0.4606	0.4223	0.4542	0.4060

Typical Electro/Optical Characteristic Curves (Ta=25°C)



Reliability Test Conditions

Test Item	Test Condition	Result	Judgment Criteria
Consecutive operating life test	IF=20mA, T=25℃, t=168h	0/100	Forward Voltage $VF(V) = \text{Upper Limit} \times 1.2$ Reverse Leakage Current $IR(\mu A) = \text{Upper Limit} \times 2.0$ Luminous Intensity IV $(mcd) = \text{Lower Limit} \times 0.7$
High temperature storage life test	T=100℃, t=168h	0/100	
Low temperature storage life test	T=25℃, t=168h	0/100	
High temperature humidity storage life test	T=85 ± 2℃, RH=85% ± 3, t=168h	0/100	
Temperature cycle test	-25℃~25℃~100℃ 30min 5min 30min 10cycles	0/100	
Thermal shock test	100℃ 0℃ 5min 5min 20cycles	0/100	
Soldering heat test	T=260 ± 5℃, t=10s ± 1s	0/100	
Solderability test	T=235 ± 5℃, t=5s ± 0.5s	0/100	Steeped Part ≥ 95%
Fall test	h=100cm, 50times	0/100	Surface Appearance Photoelectric Properties Intact
Terminal strength test	W=9.8N, t=30 ± 5s	0/100	
Lead bending test	W=4.9N, 2times	0/100	